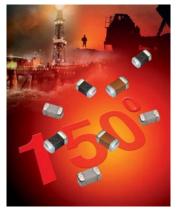
X8R/X8L Dielectric







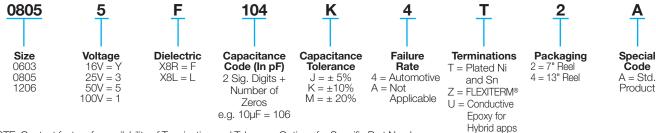
AVX has developed a range of multilayer ceramic capacitors designed for use in applications up to 150°C. These capacitors are manufactured with an X8R and an X8L dielectric material. X8R material has capacitance variation of ±15% between -55°C and +150°C. The X8L material has capacitance variation of ±15% between -55°C to 125°C and +15/-40% from +125°C to +150°C.

The need for X8R and X8L performance has been driven by customer requirements for parts that operate at elevated temperatures. They provide a highly reliable capacitor with low loss and stable capacitance over temperature.

They are ideal for automotive under the hood sensors, and various industrial applications. Typical industrial application would be drilling monitoring system. They can also be used as bulk capacitors for high temperature camera modules.

Both X8R and X8L dielectric capacitors are automotive AEC-Q200 qualified. Optional termination systems, tin, FLEXITERM® and conductive epoxy for hybrid applications are available. Providing this series with our FLEXITERM® termination system provides further advantage to customers by way of enhanced resistance to both, temperature cycling and mechanical damage.

PART NUMBER (see page 2 for complete part number explanation)



NOTE: Contact factory for availability of Termination and Tolerance Options for Specific Part Numbers.

X8R X8L

,	SIZE		603	0805			1206	
	WVDC	25V	50V	25V	50V	25V	50V	
331	Cap 330	G	G	J	J			
471	(pF) 470	G	G	J	J			
681	680	G	G	J	J			
102	1000	G	G	J	J	J	J	
152	1500	G	G	J	J	J	J	
222	2200	G	G	J	J	J	J	
332	3300	G	G	J	J	J	J	
472	4700	G	G	J	J	J	J	
682	6800	G	G	J	J	J	J	
103	Cap 0.01	G	G	J	J	J	J	
153	(μF) 0.015	G	G	J	J	J	J	
223	0.022	G	G	J	J	J	J	
333	0.033	G	G	J	J	J	J	
473	0.047	G	G	J	J	J	J	
683	0.068	G		N	N	М	M	
104	0.1			N	N	М	M	
154	0.15			N	N	М	М	
224	0.22			N		М	М	
334	0.33					М	M	
474	0.47					М		
684	0.68							
105	1							
	WVDC	25V	50V	25V	50V	25V	50V	
	SIZE	06	603	08	305	06		

SIZE			0603	0805 12					206		
	WVDC	25V	50V	100V	25V	50V	100V	16V	25V	50V	100V
331	Cap 330		G	G		J	J				
471	(pF) 470		G	G		J	J				
681	680		G	G		J	J				
102	1000		G	G		J	J				
152	1500		G	G		J	J			J	J
222	2200		G	G		J	J			J	J
332	3300		G	G		J	J			J	J
472	4700		G	G		J	J			J	J
682	6800		G	G		J	J			J	J
103	Cap 0.01		G	G		J	J			J	J
153	(µF) 0.015	G	G		J	J	J			J	J
223	0.022	G	G		J	J	J			J	J
333	0.033	G	G		J	J	N			J	J
473	0.047	G	G		J	J	N			J	J
683	0.068	G	G		J	J				J	J
104	0.1	G	G		J	J				J	М
154	0.15				J	N		J	J	J	Q
224	0.22				N	N		J	J	J	Q
334	0.33				N			J	М	Р	Q
474	0.47				N			М	М	Р	
684	0.68							М			
105	1							М			
	WVDC	25V	50V	100V	25V	50V	100V	16V	25V	50V	100V
	SIZE		0603		0805			1206			

Letter	А	С	Е	G	J	K	М	N	Р	Q	Х	Υ	Z
Max.	0.33	0.56	0.71	0.90	0.94	1.02	1.27	1.40	1.52	1.78	2.29	2.54	2.79
Thickness	(0.013)	(0.022)	(0.028)	(0.035)	(0.037)	(0.040)	(0.050)	(0.055)	(0.060)	(0.070)	(0.090)	(0.100)	(0.110)
	PAPER					EMBOSSED							

= AEC-Q200 Qualified

X8R/X8L Dielectric

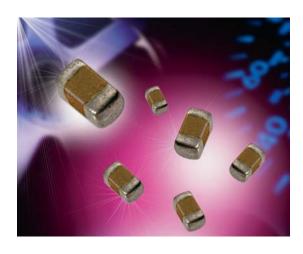
General Specifications

www.DanSkeet/Uron

APPLICATIONS FOR X8R AND X8L CAPACITORS

- All market sectors with a 150°C requirement
- Automotive on engine applications
- Oil exploration applications
- Hybrid automotive applications
 - Battery control
 - Inverter / converter circuits
 - Motor control applications
 - Water pump
- Hybrid commercial applications
 - Emergency circuits
 - Sensors
 - Temperature regulation



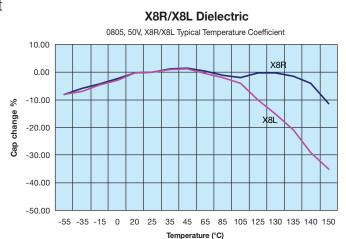


ADVANTAGES OF X8R AND X8L MLC CAPACITORS

- Both ranges are qualified to the highest automotive AEC-Q200 standards
- Excellent reliability compared to other capacitor technologies
- RoHS compliant
- Low ESR / ESL compared to other technologies
- Tin solder finish
- FLEXITERM® available
- Epoxy termination for hybrid available
- 100V range available

ENGINEERING TOOLS FOR HIGH VOLTAGE MLC CAPACITORS

- Samples
- Technical Articles
- Application Engineering
- Application Support





X8R/X8L Dielectric



Specifications and Test Methods

Parameter/Test		X8R/X8L Specification Limits	Measuring Conditions				
Operating Temperature Range		-55°C to +150°C	Temperature Cycle Chamber				
Capacitance		Within specified tolerance	Freq.: 1.0 kHz ± 10%				
Dissipation Factor		\leq 2.5% for \geq 50V DC rating \leq 3.5% for 25V DC and 16V DC rating	Voltage: 1.0				
Insulation	Posistanos	100,000MΩ or 1000MΩ - μF,	Charge device with rated voltage for 120 ± 5 secs @ room temp/humidity				
IIISUIALIOII	nesisiance	whichever is less					
Dielectric Strength		No breakdown or visual defects	Charge device with 300% of rated voltage for 1-5 seconds, w/charge and discharge current limited to 50 mA (max) Note: Charge device with 150% of rated voltage for 500V devices.				
	Appearance	No defects	Deflectio	n: 2mm			
	Capacitance	≤ ±12%	Test Time: 3	30 seconds			
Resistance to	Variation	S ± 1 ≥ 70	∇	7 1mm/sec			
Flexure Stresses	Dissipation Factor	Meets Initial Values (As Above)	V				
	Insulation	≥ Initial Value x 0.3					
	Resistance		90 mm —				
Solderability		≥ 95% of each terminal should be covered with fresh solder	Dip device in eutectic solder at 230 \pm 5 for 5.0 \pm 0.5 seconds				
	Appearance	No defects, <25% leaching of either end terminal					
	Capacitance	≤ ±7.5%					
	Variation		Dip device in eutectic solder at 260°C for 60				
Resistance to	Dissipation	Meets Initial Values (As Above)	seconds. Store at room temperature for 24 ± 2				
Solder Heat	Factor		hours before measuring				
	Insulation Resistance	Meets Initial Values (As Above)					
	Dielectric	<u> </u>					
	Strength	Meets Initial Values (As Above)					
	Appearance	No visual defects	Step 1: -55°C ± 2°	30 ± 3 minutes			
	Capacitance Variation	≤ ±7.5%	Step 2: Room Temp	≤ 3 minutes			
Thermal Shock	Dissipation Factor	Meets Initial Values (As Above)	Step 3: +125°C ± 2°	30 ± 3 minutes			
SHOCK	Insulation Resistance	Meets Initial Values (As Above)	Step 4: Room Temp	≤ 3 minutes			
	Dielectric	Meets Initial Values (As Above)	Repeat for 5 cycles ar	nd measure after			
	Strength		24 ± 2 hours at room temperature				
	Appearance	No visual defects	Charge device with 1.5 rated voltage (≤ 10V)				
Load Life	Capacitance Variation	≤ ±12.5%	test chamber set				
	Dissipation						
	Factor	≤ Initial Value x 2.0 (See Above)	for 1000 hours (+48, -0)				
	Insulation		Remove from test ch	namber and stabilize			
	Resistance	≥ Initial Value x 0.3 (See Above)	at room temperature for 24 ± 2 hours before measuring.				
	Dielectric	NA - + -					
	Strength	Meets Initial Values (As Above)	3				
	Appearance	No visual defects	Store in a tost chamber set at 9500 · 900/				
	Canacitanas	≤ ±12.5%	Store in a test chamber set at 85° C \pm 2° C/ 85° \pm 5° relative humidity for 1000 hours (+48, -0) with rated voltage applied.				
	Capacitance						
	Variation	S ±12.570					
Load	Variation Dissipation						
Load Humidity	Variation Dissipation Factor	≤ Initial Value x 2.0 (See Above)		d voltage applied.			
	Variation Dissipation Factor Insulation		(+48, -0) with rated Remove from cham room temperature	d voltage applied. ber and stabilize at and humidity for			
	Variation Dissipation Factor	≤ Initial Value x 2.0 (See Above)	(+48, -0) with rated Remove from cham	d voltage applied. ber and stabilize at and humidity for			